International IOR Rectifier

AUTOMOTIVE GRADE

AUIRL1404Z AUIRL1404ZS AUIRL1404ZL

HEXFET® Power MOSFET

Features

- Logic Level
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching

Description

applications.

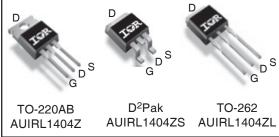
• Repetitive Avalanche Allowed up to Timax

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low onresistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other

- · Lead-Free, RoHS Compliant
- Automotive Qualified *

G

V _{(BR)DSS}	40V
R _{DS(on)} ty	o. 2.5m Ω
m	ax. 3.1mΩ
I _{D (Silicon Limit}	ted) 180A ®
I _{D (Package Lii}	nited) 160A



D REPORT OF S	received a second	g G
TO-220AB	D ² Pak	TO-262
AUIRL1404Z	AUIRL1404ZS	AUIRL1404ZL

Absolute Maximum Ratings

Gate Drain Source Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	180®	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V(Silicon Limited)	130	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V(Package Limited)	160	Π ^
I _{DM}	Pulsed Drain Current ①	790	
P _D @T _C = 25°C	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally limited) ②	190	mJ
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value ®	490	1110
I _{AR}	Avalanche Current ①	See Fig.12a, 12b, 15, 16	Α
E _{AR}	Repetitive Avalanche Energy ©		mJ
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		0.75 ⑨	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface ♡	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient ⑦		62	*C/VV
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ®		40	

HEXFET® is a registered trademark of International Rectifier.

*Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			٧	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.034		V/°C	Reference to 25°C, I _D = 1mA
			2.5	3.1		V _{GS} = 10V, I _D = 75A ③* *
R _{DS(on)}	Static Drain-to-Source On-Resistance			4.7	mΩ	V _{GS} = 5.0V, I _D = 40A ③
				5.9		$V_{GS} = 4.5V, I_D = 40A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	1.4		2.7	٧	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Transconductance	120			S	$V_{DS} = 10V, I_D = 75A^*$
I _{DSS}	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 40V, V_{GS} = 0V$
				250		$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	nA	V _{GS} = 16V
	Gate-to-Source Reverse Leakage			-200		$V_{GS} = -16V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

_ ya		`	(or opermou)
	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		75	110		I _D = 75A* *
Q_{gs}	Gate-to-Source Charge		28		nC	$V_{DS} = 32V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		40		1	V _{GS} = 5.0V ③
t _{d(on)}	Turn-On Delay Time		19			$V_{DD} = 20V$
t _r	Rise Time		180		1	I _D = 75A* *
t _{d(off)}	Turn-Off Delay Time		30		ns	$R_G = 4.0\Omega$
t _f	Fall Time		49		1	V _{GS} = 5.0V ③
L _D	Internal Drain Inductance		4.5			Between lead,
					nH	6mm (0.25in.)
L _S	Internal Source Inductance		7.5		1	from package G
			l			and center of die contact
C _{iss}	Input Capacitance		5080			$V_{GS} = 0V$
C _{oss}	Output Capacitance		970			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		570		pF	f = 1.0MHz
C _{oss}	Output Capacitance		3310	_	Ī	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C _{oss}	Output Capacitance		870	_	Ī	$V_{GS} = 0V, V_{DS} = 32V, f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance		1280	_	Ī	$V_{GS} = 0V$, $V_{DS} = 0V$ to 32V \oplus
	•					

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			180		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current			720		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	٧	$T_J = 25^{\circ}C$, $I_S = 75A^{**}$, $V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		26	39		$T_J = 25^{\circ}C$, $I_F = 75A^{**}$, $V_{DD} = 20V$
Q _{rr}	Reverse Recovery Charge		18	27	nC	di/dt = 100A/µs ③
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

Note ① through ⑩ ,* * are on page 3

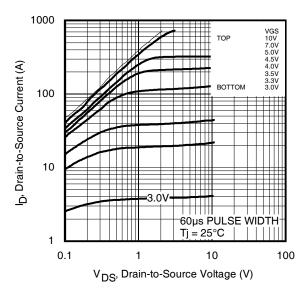
Qualification Information[†]

			Automotive (per AEC-Q101) ††			
Qualification Level		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
		3L-D2 PAK	MSL1			
Moisture Sensi	Moisture Sensitivity Level		N/A			
		3L-TO-220	IVA			
	Machine Model	Class M4 (425V)				
	Machine Model	(per AEC-Q101-002)				
505			Class H1C (2000V)			
ESD	Human Body Model	(per AEC-Q101-001)				
		Class C5 (1125V)				
	Charged Device Model	(per AEC-Q101-005)				
RoHS Complian	nt	Yes				

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Exceptions to AEC-Q101 requirements are noted in the qualification report.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- $\ensuremath{\text{@}}$ Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 0.066mH, R_{G} = 25 $\!\Omega,\,I_{AS}$ = 75 A, V_{GS} =10 V. Part not recommended for use above this value.
- time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- $\ \, \ \, \ \,$ Limited by T_{Jmax} , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- $\ensuremath{\mathfrak{G}}$ This value determined from sample failure population. 100% tested to this value in production.
- $\ensuremath{\mathfrak{D}}$ This is only applied to TO-220AB package.
- ® When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- $\ \, ^{\mbox{\scriptsize 0}}$ TO-220 device will have an Rth value of 0.65°C/W.
- temperature. Bond wire current limit is 160A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
 - ** All AC and DC test conditions based on former package limited



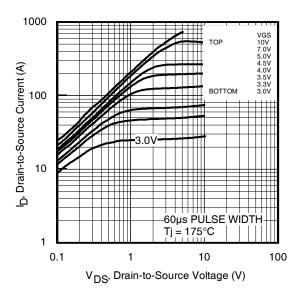
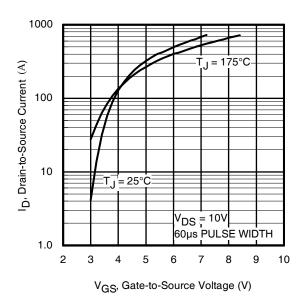


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



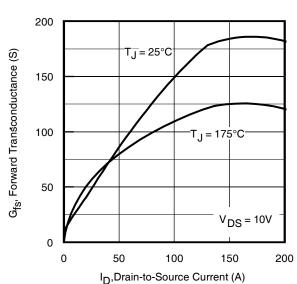
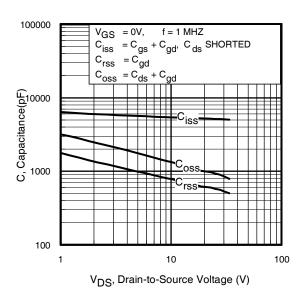


Fig 3. Typical Transfer Characteristics

Fig 4. Typical Forward Transconductance vs. Drain Current



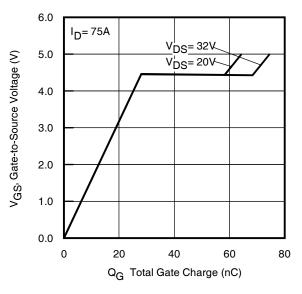
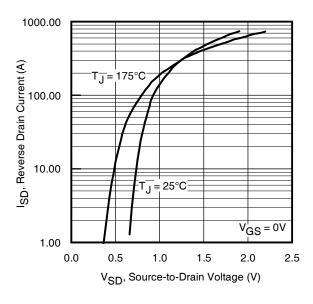


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



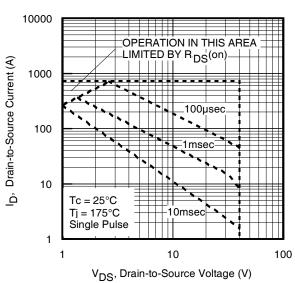
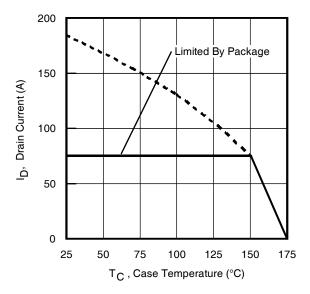


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



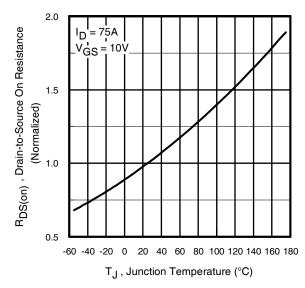


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

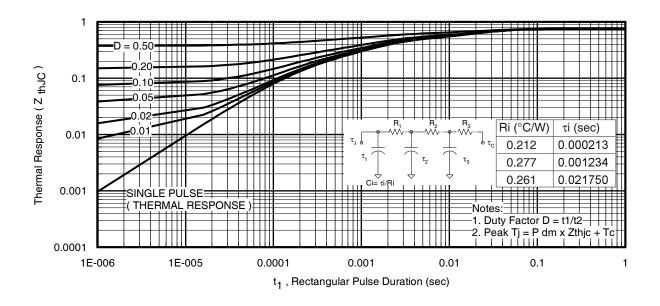


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

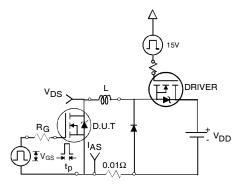


Fig 12a. Unclamped Inductive Test Circuit

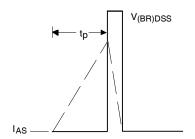


Fig 12b. Unclamped Inductive Waveforms

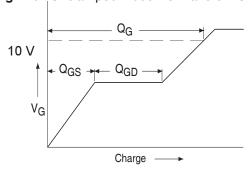


Fig 13a. Basic Gate Charge Waveform

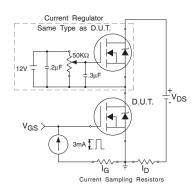


Fig 13b. Gate Charge Test Circuit www.irf.com

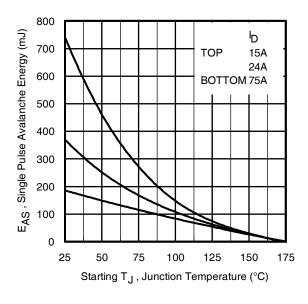


Fig 12c. Maximum Avalanche Energy vs. Drain Current

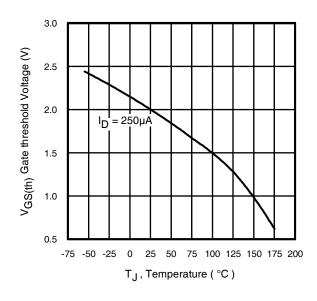


Fig 14. Threshold Voltage vs. Temperature

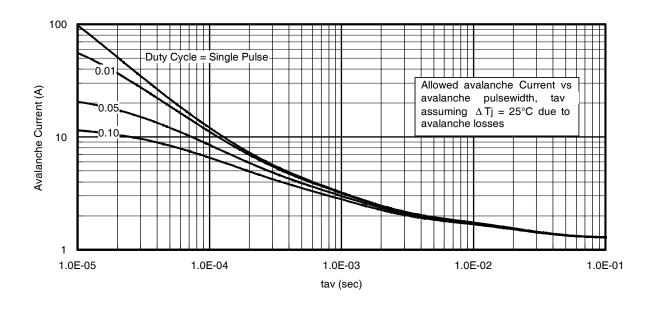


Fig 15. Typical Avalanche Current vs. Pulsewidth

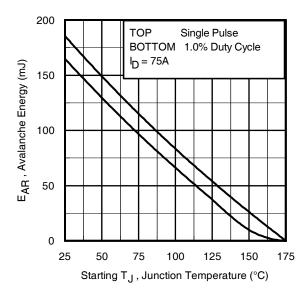


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16). t_{av} = Average time in avalanche.
 - $D = Duty cycle in avalanche = t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \triangle T/ \; Z_{thJC} \\ I_{av} &= 2\triangle T/ \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

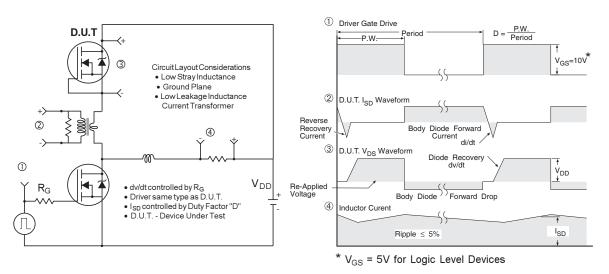


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

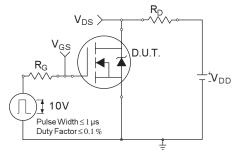


Fig 18a. Switching Time Test Circuit

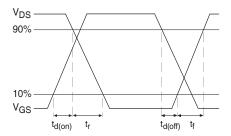
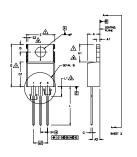


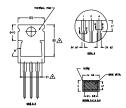
Fig 18b. Switching Time Waveforms

International IOR Rectifier

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





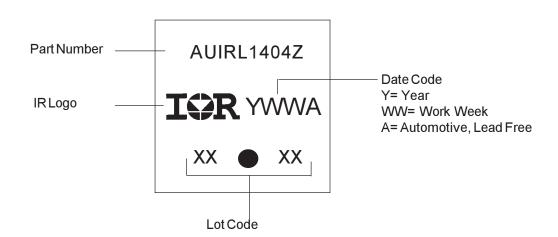
- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M— 1994,
 DIMENSIONING ARE SHOWN IN INCHES [MILLIMETERS],
 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1,
 DIMENSION D & E DO NOT INCLIDE MOLD FLASH, MOLD FLASH
 SHALL NOT EXCEED .005" (0.127) PER SIDE, THESE DIMENSIONS ARE
 MEASURED AT THE OUTERNOST EXTREMES OF THE PLASTIC BODY,
 DIMENSION D & c1 APPLY TO BASE METAL ONLY.
 CONTROLLING DIMENSION: INCHES.
 THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
 DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING
 AND SINGULATION IRREGULARITIES ARE ALLOWED.

SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	3.56	4.82	.140	.190	
A1	0.51	1,40	.020	,055	
A2	2.04	2.92	.080	,115	
ь	0.38	1,01	.015	.040	
ь1	0.38	0.96	.015	.038	5
b2	1,15	1,77	.045	,070	
b3	1,15	1,73	.045	,068	
С	0.36	0,61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14,22	16,51	.560	,650	4
D1	8,38	9.02	.330	.355	
D2	12.19	12.88	.480	.507	7
E	9.66	10.66	.380	.420	4,7
E1	8.38	8.89	.330	.350	7
e	2.54	BSC	.100	BSC	
e1	5.	08	.200	BSC	
H1	5.85	6.55	.230	.270	7,8
L	12.70	14,73	.500	.580	
L1	-	6.35	-	.250	3
αD	7.54	1 A A O I	130	161	1

LEAD ASSIGNMENTS

HEXFET

TO-220AB Part Marking Information



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2,54

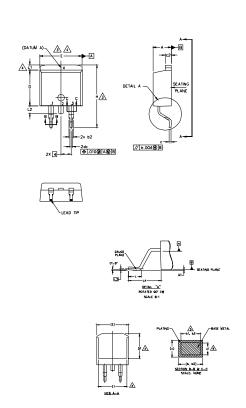
3,42

.100

.135

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/ 10 www.irf.com

$D^2 Pak \ \ Package \ \ Outline \ \ \ (\hbox{\tiny Dimensions are shown in millimeters (inches)})$



- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3.\DMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND 61 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7, CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S M B O		Ŋ				
B	MILLIM	MILLIMETERS		HES	Ö	
L	MIN.	MAX.	MIN.	MAX.	É S	
Α	4.06	4.83	.160	,190		
A1	0.00	0.254	.000	.010		
ь	0.51	0,99	.020	.039		
ь1	0.51	0.89	.020	.035	5	
b2	1,14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1,14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6,86	-	.270		4	
Ε	9.65	10.67	.380	.420	3,4	
E1	6.22	-	.245		4	
e	2.54	BSC	.100	BSC		
Н	14,61	15,88	.575	.625		
L	1.78	2.79	.070	.110		
L1	-	1.65	-	.066	4	
L2	1.27	1.78	-	.070		
L3	0.25	BSC	.010	BSC		
L4	4.78	5.28	.188	.208		

LEAD ASSIGNMENTS

HEXFET

1.- GATE 2. 4.- DRAIN 3.- SOURCE

IGBTs, CoPACK

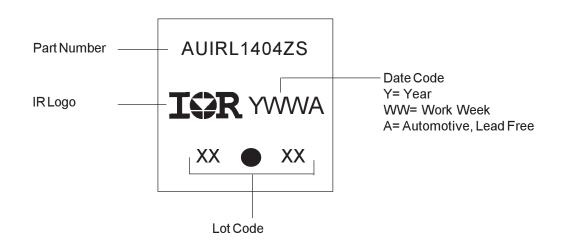
1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE • 4.- CATHODE 3.- ANODE

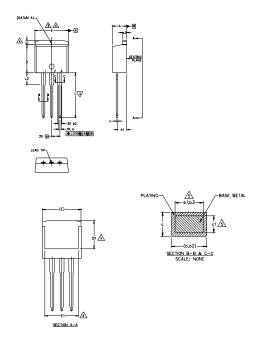
* PART DEPENDENT

D²Pak Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/ www.irf.com

TO-262 Package Outline (Dimensions are shown in millimeters (inches))



- 1, DIMENSIONING AND TOLERANCING PER ASME Y14,5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3\DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND C1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S M B O			N		
B	MILLIM	ETERS	INC	INCHES	
Ľ	MIN.	MAX.	MIN.	MAX.	N O T E S
Α	4,06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1,14	1,78	.045	.070	
b3	1,14	1,73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6,86	-	.270	-	4
Ε	9,65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
e	2,54	BSC	.100	BSC	
L	13,46	14,10	.530	.555	
L1	-	1.65	-	.065	4
L2	3,56	3,71	.140	.146	

LEAD ASSIGNMENTS

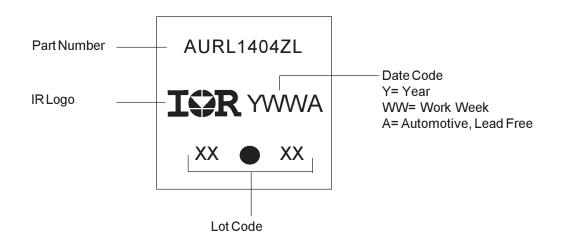
HEXFET

- 1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

IGBTs, CoPACK

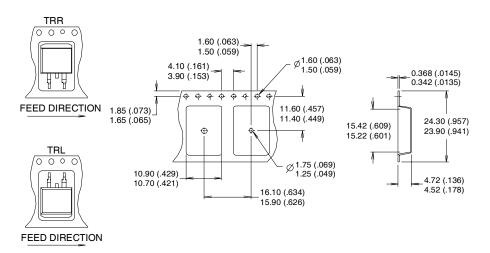
- 1.- GATE
 2.- COLLECTOR
 3.- EMITTER
 4.- COLLECTOR

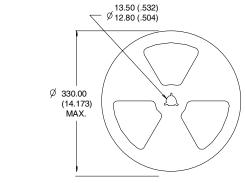
TO-262 Part Marking Information

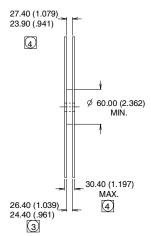


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

D²Pak Tape & Reel Infomation







- NOTES:

 1. COMFORMS TO EIA-418.

 2. CONTROLLING DIMENSION: MILLIMETER.

 3. DIMENSION MEASURED @ HUB.

 4. INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Ordering Information

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRL1404Z	TO-220	Tube	50	AUIRL1404Z
AUIRL1404ZL	TO-262	Tube	50	AUIRL1404ZL
AUIRL1404ZS	D2Pak	Tube	50	AUIRL1404ZS
		Tape and Reel Left	800	AUIRL1404ZSTRL
		Tape and Reel Right	800	AUIRL1404ZSTRR

International TOR Rectifier

AUIRL1404Z/S/L

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